

# DATA SHEET

## **CBTD16211**

24-bit level shifting bus exchange switch  
with 12-bit output enables

Product data

2001 Jun 13

# 24-bit level shifting bus exchange switch with 12-bit output enables

CBTD16211

## FEATURES

- 5Ω switch connection between two ports
- TTL compatible control input levels
- Designed to be used in level shifting applications
- Package options include shrink small outline (SSOP) and thin shrink small outline (TSSOP)
- ESD protection exceeds 1000 V CDM per JESD22-C101
- Latch-up testing is done to JESDEC Standard JESD78 which exceeds 100 mA

## DESCRIPTION

The CBTD16211 provides 24 bits of high-speed TTL-compatible bus switching. The low on-state resistance of the switch allows connections to be made with minimal propagation delay.

A diode to  $V_{CC}$  is integrated in the circuit to allow for level shifting between 5 V inputs and 3.3 V outputs.

The device is organized as a dual 12-bit bus switch with separate output-enable ( $\overline{OE}$ ) inputs. It can be used as two 10-bit bus switches or as one 20-bit bus switch. When  $\overline{OE}$  is low, the associated 10-bit bus switch is on, and port A is connected to port B. When  $\overline{OE}$  is high, the switch is open, and a high-impedance state exists between the ports.

The CBTD16211 is characterized for operation from  $-40$  to  $+85$  °C.

## QUICK REFERENCE DATA

SYMBOL	PARAMETER	CONDITIONS $T_{amb} = 25$ °C; $GND = 0$ V	TYPICAL	UNIT
$t_{PLH}$ $t_{PHL}$	Propagation delay An to Yn	$C_L = 50$ pF; $V_{CC} = 5$ V	0.25	ns
$C_{IN}$	Input capacitance	$V_I = 0$ V or $V_{CC}$	4.3	pF
$C_{OUT}$	Output capacitance	Outputs disabled; $V_O = 0$ V or $V_{CC}$	6.9	pF
$I_{CC}$	Total supply current	Outputs disabled; $V_{CC} = 5.5$ V	3.0	μA

## ORDERING INFORMATION

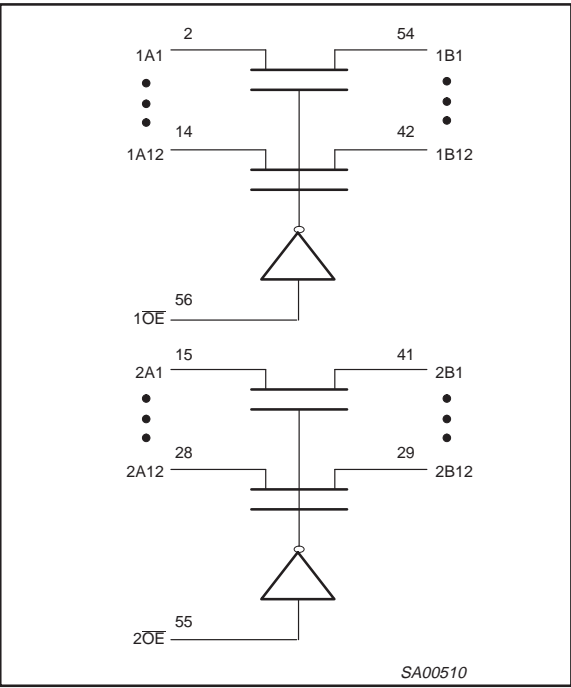
PACKAGES	TEMPERATURE RANGE	ORDER CODE	DWG NUMBER
56-Pin Plastic SSOP Type III	$-40$ to $+85$ °C	CBTD16211DL	SOT371-1
56-Pin Plastic TSSOP Type II	$-40$ to $+85$ °C	CBTD16211DGG	SOT364-1

## FUNCTION TABLE

INPUTS		OUTPUTS	
$1\overline{OE}$	$2\overline{OE}$	1A, 1B	2A, 2B
L	L	1A = 1B	2A = 2B
L	H	1A = 1B	Z
H	L	Z	2A = 2B
H	H	Z	Z

H = High voltage level  
L = Low voltage level  
Z = High impedance "off" state

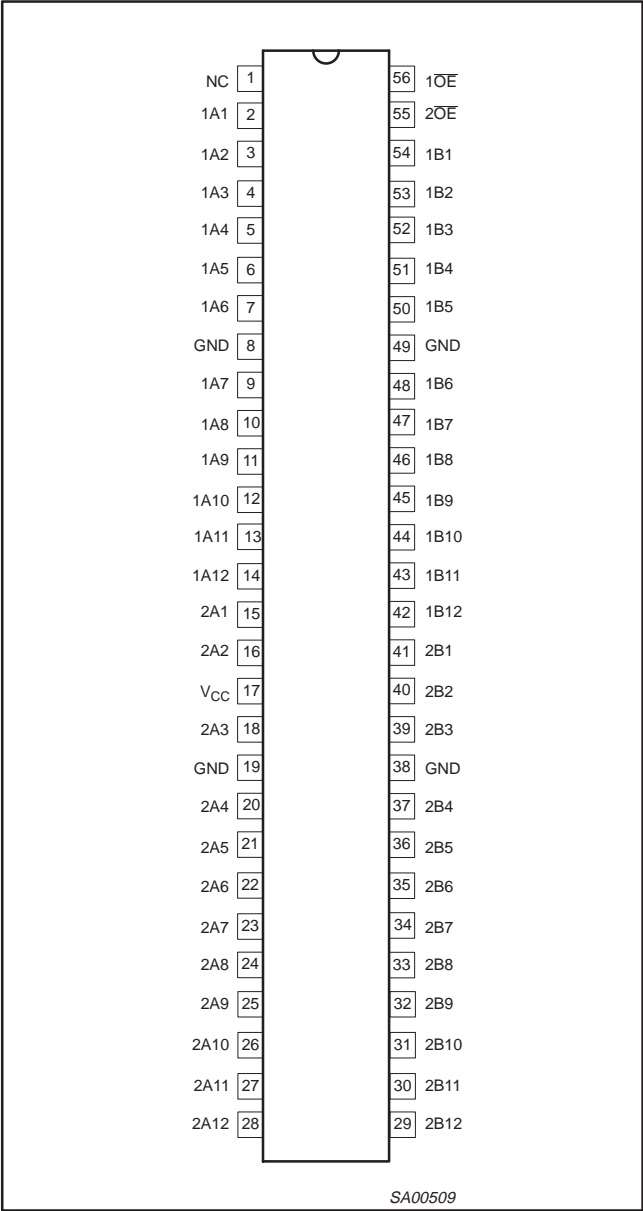
## LOGIC SYMBOL



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PIN CONFIGURATION



PIN DESCRIPTION

PIN NUMBER	SYMBOL	NAME AND FUNCTION
1	NC	No internal connection
56, 55	1OE, 2OE	Output enables
2, 3, 4, 5, 6, 7, 9, 10, 11, 12, 13, 14	1A1-1A12	Inputs
54, 53, 52, 51, 50, 48, 47, 46, 45, 44, 43, 42	1B1-1B12	Outputs
15, 16, 18, 20, 21, 22, 23, 24, 25, 26, 27, 28	2A1-2A12	Inputs
41, 40, 39, 37, 36, 35, 34, 33, 32, 31, 30, 29	2B1-2B12	Outputs
8, 19, 38, 49	GND	Ground (0 V)
17	VCC	Positive supply voltage

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## ABSOLUTE MAXIMUM RATINGS<sup>1, 2</sup>

SYMBOL	PARAMETER	CONDITIONS	RATING	UNIT
$V_{CC}$	DC supply voltage		-0.5 to +7.0	V
$I_{IK}$	DC input diode current	$V_I < 0$	-50	mA
$V_I$	DC input voltage <sup>3</sup>		-0.5 to +7.0	V
$V_{OUT}$	DC output voltage <sup>3</sup>	output in Off or High state	-0.5 to +5.5	V
$I_{OUT}$	DC output current	output in Low state	128	mA
$T_{stg}$	Storage temperature range		-65 to +150	°C

### NOTES:

- Stresses beyond those listed may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
- The performance capability of a high-performance integrated circuit in conjunction with its thermal environment can create junction temperatures which are detrimental to reliability. The maximum junction temperature of this integrated circuit should not exceed 150 °C.
- The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

## RECOMMENDED OPERATING CONDITIONS

SYMBOL	PARAMETER	LIMITS		UNIT
		Min	Max	
$V_{CC}$	DC supply voltage	4.5	5.5	V
$V_{IH}$	High-level input voltage	2.0	—	V
$V_{IL}$	Low-level Input voltage	—	0.8	V
$T_{amb}$	Operating free-air temperature range	-40	+85	°C

## DC ELECTRICAL CHARACTERISTICS

SYMBOL	PARAMETER	TEST CONDITIONS	LIMITS			UNIT
			T <sub>amb</sub> = −40 to +85 °C			
			Min	Typ <sup>1</sup>	Max	
V <sub>IK</sub>	Input clamp voltage	V <sub>CC</sub> = 4.5 V; I <sub>I</sub> = −18 mA	—	—	−1.2	V
V <sub>OH</sub>	Output high pass voltage	See Figure 1	—	—		V
I <sub>I</sub>	Input leakage current	V <sub>CC</sub> = 0 V; V <sub>I</sub> = 5.5 V	—	—	10	μA
		V <sub>CC</sub> = 5.5 V; V <sub>I</sub> = GND or 5.5 V	—	—	±1	
I <sub>CC</sub>	Quiescent supply current	V <sub>CC</sub> = 5.5 V; I <sub>O</sub> = 0, V <sub>I</sub> = V <sub>CC</sub> or GND; 1OE=2OE=GND	—	—	1.5	mA
ΔI <sub>CC</sub>	Additional supply current per input pin <sup>2</sup>	V <sub>CC</sub> = 5.5 V, one input at 3.4 V, other inputs at V <sub>CC</sub> or GND	—	—	2.5	mA
C <sub>I</sub>	Control pins	V <sub>I</sub> = 3 V or 0	—	4.5	—	pF
C <sub>I(OFF)</sub>	Port OFF capacitance	V <sub>O</sub> = 3 V or 0, $\overline{OE}$ = V <sub>CC</sub>	—	8	—	pF
r <sub>on</sub> <sup>3</sup>		V <sub>CC</sub> = 4.5 V; V <sub>1</sub> = 0 V; I <sub>I</sub> = 64 mA	—	5	7	Ω
		V <sub>CC</sub> = 4.5 V; V <sub>1</sub> = 0 V; I <sub>I</sub> = 30 mA	—	5	7	
		V <sub>CC</sub> = 4.5 V; V <sub>1</sub> = 2.4 V; I <sub>I</sub> = −15 mA	—	35	50	

### NOTES:

- All typical values are at  $V_{CC} = 5 \text{ V}$ ,  $T_{amb} = 25 \text{ °C}$ .
- This is the increase in supply current for each input that is at the specified TTL voltage level rather than  $V_{CC}$  or GND.
- Measured by the voltage drop between the A and the B terminals at the indicated current through the switch. On-state resistance is determined by the lowest voltage of the two (A or B) terminals.

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## AC CHARACTERISTICS

GND = 0 V;  $t_R$ ;  $C_L$  = 50 pF

SYMBOL	PARAMETER	FROM (INPUT)	TO (OUTPUT)	$V_{CC} = 5.0 \text{ V} \pm 0.5 \text{ V}$		UNIT
				Min	Max	
$t_{pd}$	Propagation delay <sup>1</sup>	A or B	B or A	—	0.25	ns
$t_{en}$	Output enable time to High and Low level	$\overline{OE}$	A or B	1.5	8.5	ns
$t_{dis}$	Output disable time from High and Low level	$\overline{OE}$	A or B	1.5	7	ns

### NOTE:

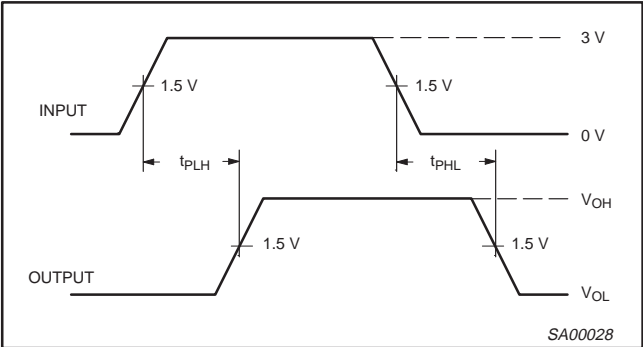
1. This parameter is warranted but not production tested. The propagation delay is based on the RC time constant of the typical on-state resistance of the switch and a load capacitance of 50 pF, when driven by an ideal voltage source (zero output impedance).

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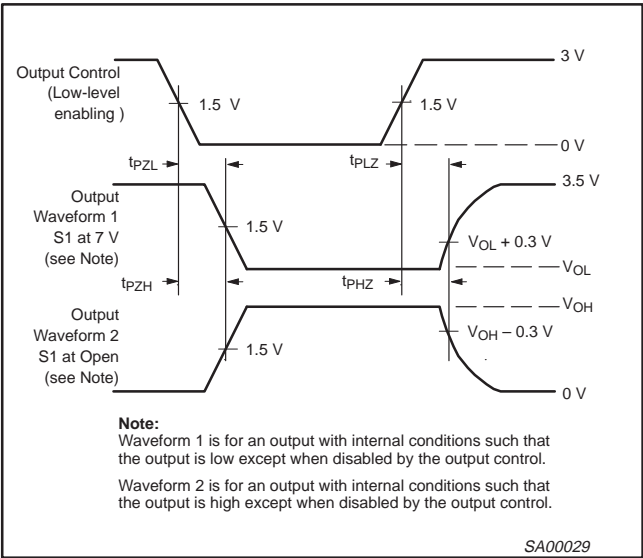
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AC WAVEFORMS

$V_M = 1.5\text{ V}$ ,  $V_{IN} = \text{GND to } 3.0\text{ V}$



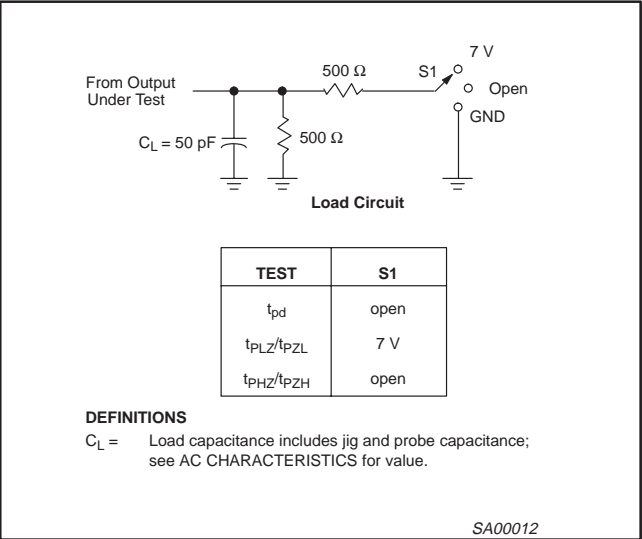
Waveform 1. Input (An) to Output (Yn) Propagation Delays



**Note:**  
Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control.  
Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.

Waveform 2. 3-State Output Enable and Disable Times

TEST CIRCUIT AND WAVEFORMS



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## TYPICAL CHARACTERISTICS

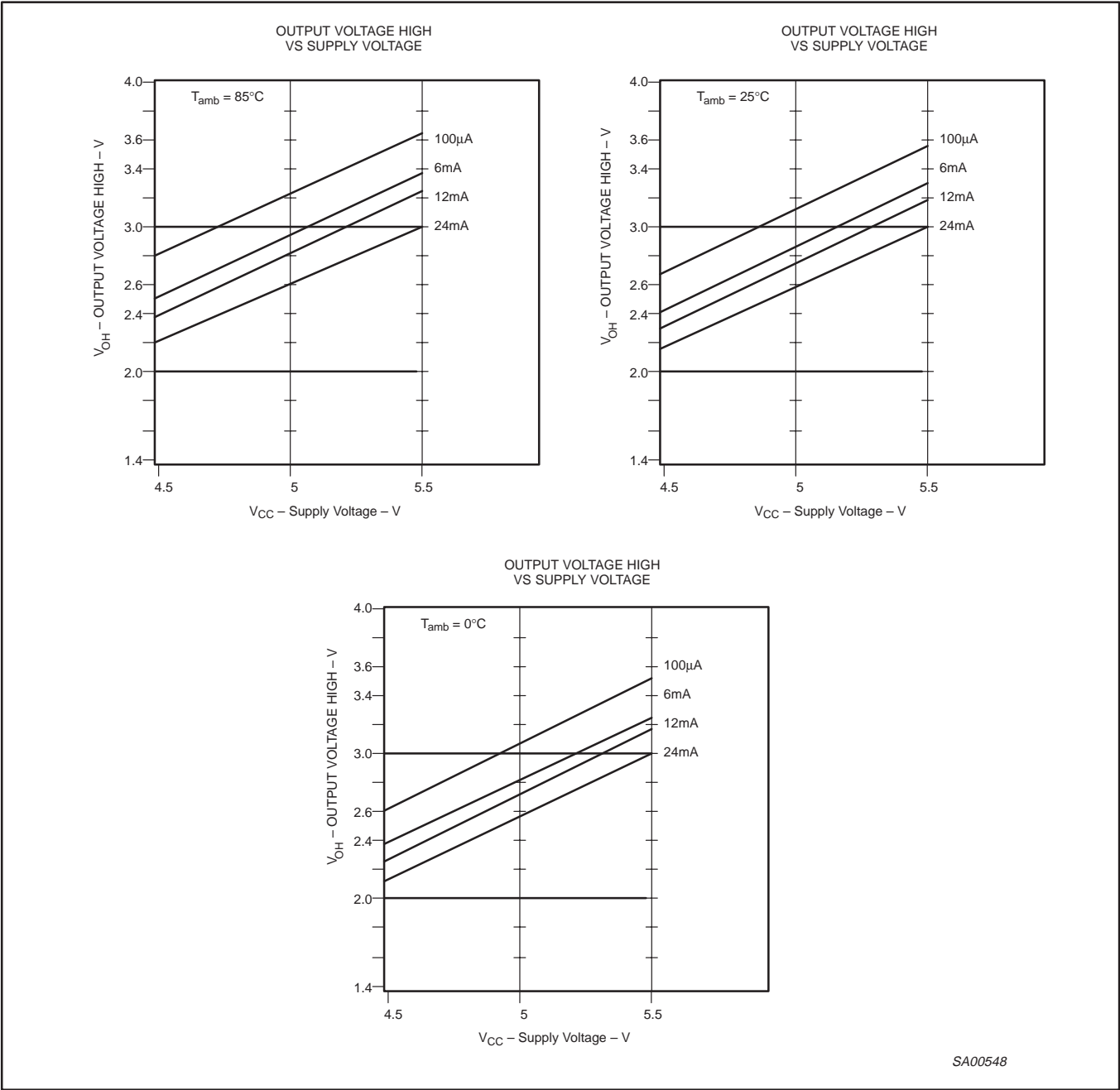


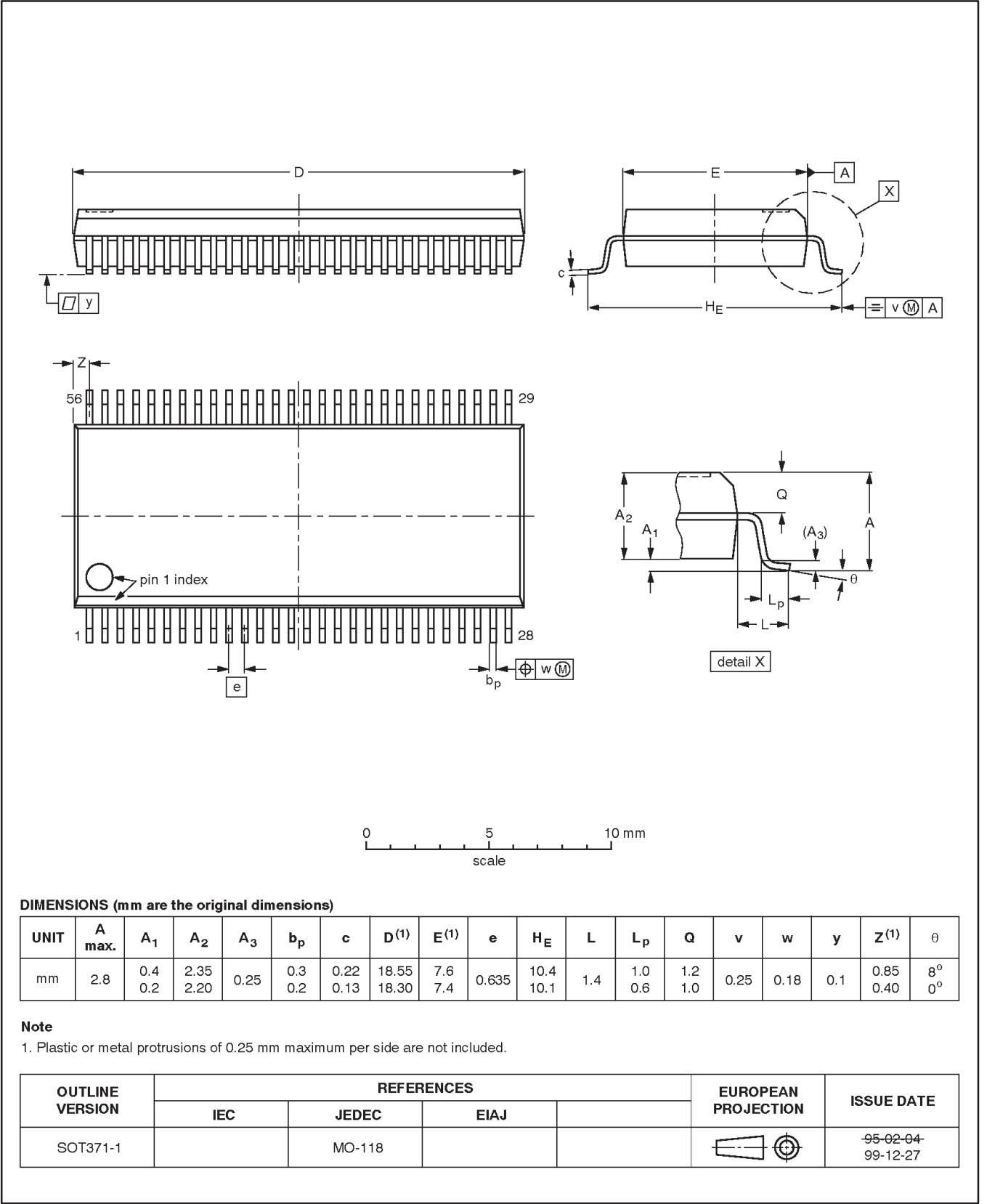
Figure 1.  $V_{OH}$  values ( $V_{in} = V_{CC}$ )

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SSOP56: plastic shrink small outline package; 56 leads; body width 7.5 mm

SOT371-1



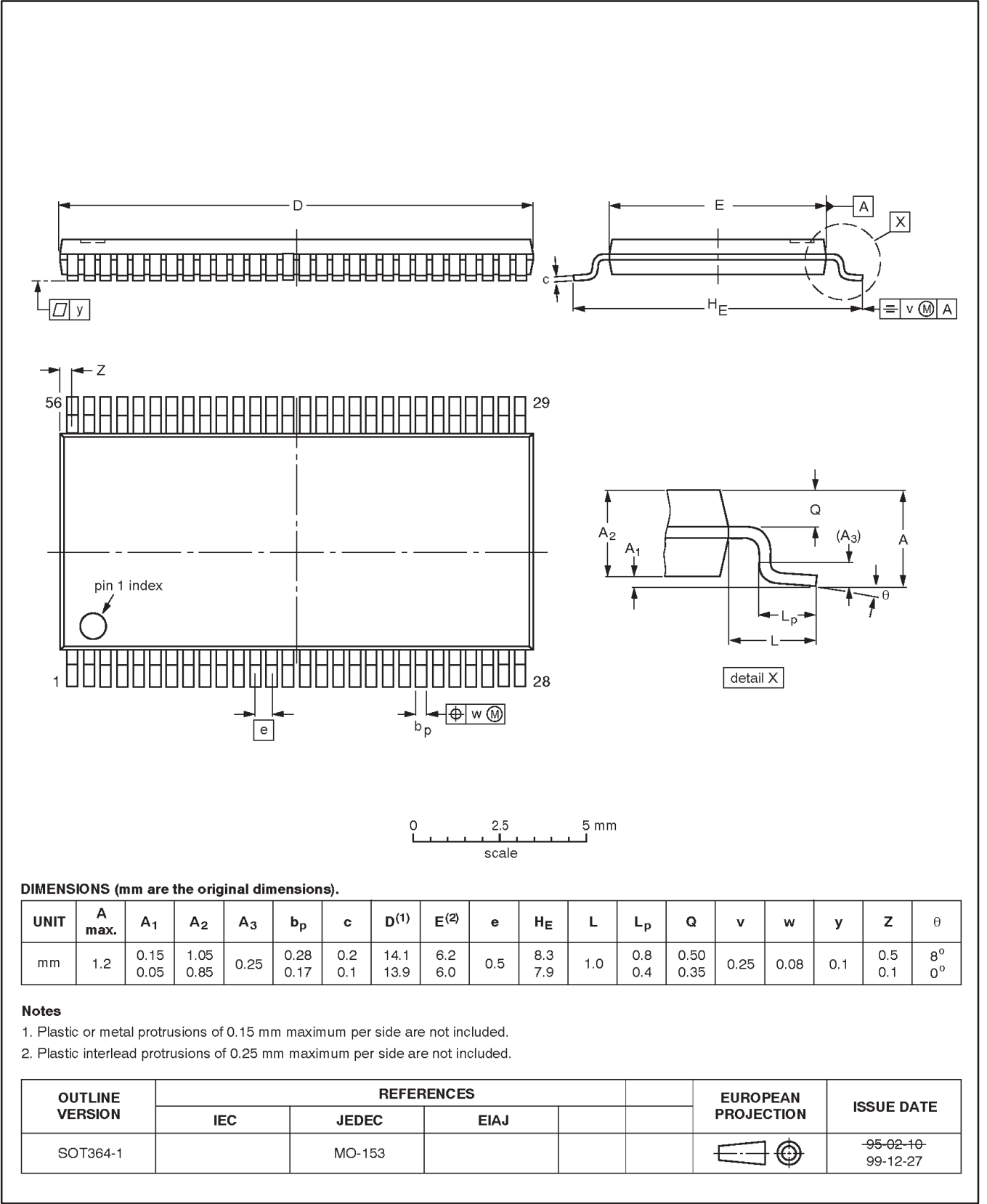


24-bit level shifting bus exchange switch  
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TSSOP56: plastic thin shrink small outline package; 56 leads; body width 6.1 mm

SOT364-1



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## Data sheet status

Data sheet status <sup>[1]</sup>	Product status <sup>[2]</sup>	Definitions
Objective data	Development	This data sheet contains data from the objective specification for product development. Philips Semiconductors reserves the right to change the specification in any manner without notice.
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[2] The product status of the device(s) described in this data sheet may have changed since this data sheet was published. The latest information is available on the Internet at URL <http://www.semiconductors.philips.com>.

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